

五、論文著述：

- (一) 請詳列個人最近五年內發表之學術性著作，包括：期刊論文、專書及專書論文、研討會論文、技術報告及其他等，並請依各類著作之重要性自行排列先後順序。
- (二) 各類著作請按發表時間先後順序填寫。各項著作請依作者姓名（按原出版之次序）、出版年、月份、題目、期刊名稱（專書出版社）、起迄頁數之順序填寫，被接受刊登尚未正式出版者請附被接受函。
- (三) 若期刊屬於 SCI、EI、SSCI 或 A&HCI 等時，請註明；若著作係經由國科會補助之研究計畫所產生，請於最後填入相關之國科會計畫編號。
- (四) 論文著述(表 C302)，請採 MS Word 97(含)以上版本輸入資料，並將輸入的檔案以 E-Mail 方式傳遞本會。E-Mail 位址：nscapply@nsc.gov.tw，Mail 之主旨請註明 C302，身分證號碼。

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● 專利

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